

## Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$I_{D} = 250 \mu A, V_{GS} = 0 V$		30			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS}$ = 30V, $V_{GS}$ = 0V				1	
			T <sub>J</sub> = 55°C			5	μA
I <sub>GSS</sub>	Gate-Body leakage current	$V_{DS} = 0V, V_{GS} = \pm 16V$				±10	
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS} I_D = 250 \mu A$		1.0	1.7	3	V
I <sub>D(ON)</sub>	On state drain current	$V_{GS}$ = 10V, $V_{DS}$ = 5V		80			Α
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10V, I <sub>D</sub> = 20A			3.8	4.6	
			T <sub>J</sub> =125°C		5.3	6.5	mΩ
		$V_{GS}$ = 4.5V, I <sub>D</sub> = 18A			5.2	6.4	
<b>g</b> <sub>FS</sub>	Forward Transconductance	$V_{DS} = 5V, I_{D} = 20A$			72		S
V <sub>SD</sub>	Diode Forward Voltage	$I_{\rm S}$ = 1A, $V_{\rm GS}$ = 0V			0.69	1	V
I <sub>S</sub>	Maximum Body-Diode Continuous Curr	ent				3	Α
DYNAMIC	PARAMETERS						
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz			5450	6800	pF
C <sub>oss</sub>	Output Capacitance				760		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				540		pF
R <sub>g</sub>	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz			1	1.5	Ω
SWITCHI	NG PARAMETERS						
Q <sub>g</sub> (10V)	Total Gate Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =20A			84	112	nC
Q <sub>g</sub> (4.5V)	Total Gate Charge				42	56	nC
Q <sub>gs</sub>	Gate Source Charge				12		nC
$Q_{gd}$	Gate Drain Charge				21		nC
t <sub>D(on)</sub>	Turn-On DelayTime				13		ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =15V, $R_{L}$ =0.75 $\Omega$ , $R_{GEN}$ =3 $\Omega$			9.8		ns
t <sub>D(off)</sub>	Turn-Off DelayTime				49		ns
t <sub>f</sub>	Turn-Off Fall Time				16		ns
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =20A, dI/dt=100A/μs			42	56	ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	I <sub>F</sub> =20A, dI/dt=100A/μs			31		nC

A: The value of R  $_{0JA}$  is measured with the device mounted on 1in <sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T  $_A$  = 25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t  $\leq$  10s thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C. The R  $_{\rm \theta JA}$  is the sum of the thermal impedence from junction to lead R  $_{\rm \theta JL}$  and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using < 300  $\mu$ s pulses, duty cycle 0.5% max.

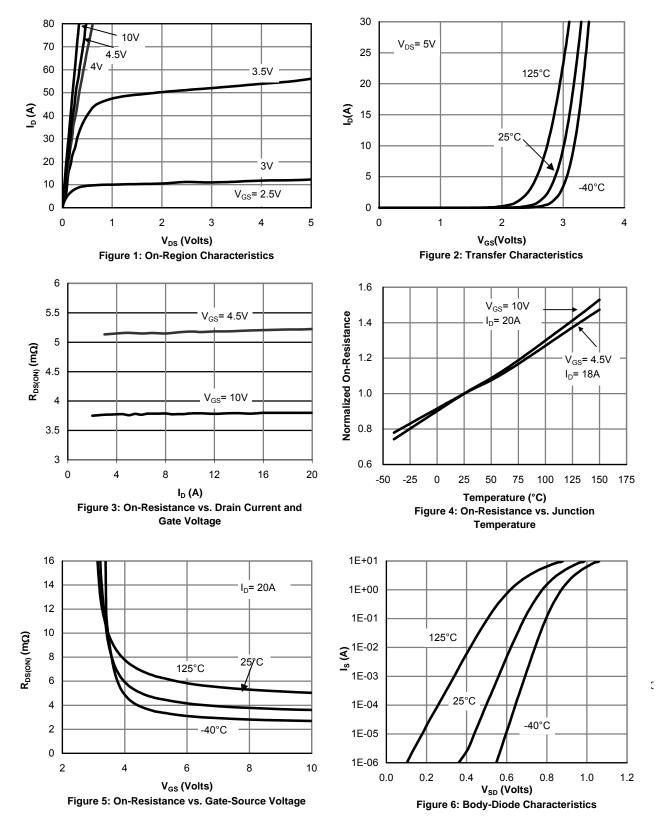
E. These tests are performed with the device mounted on 1 in  $^2$  FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The SOA curve provides a single pulse rating.

F. The current rating is based on the t  $\leq$  10s thermal resistance rating.

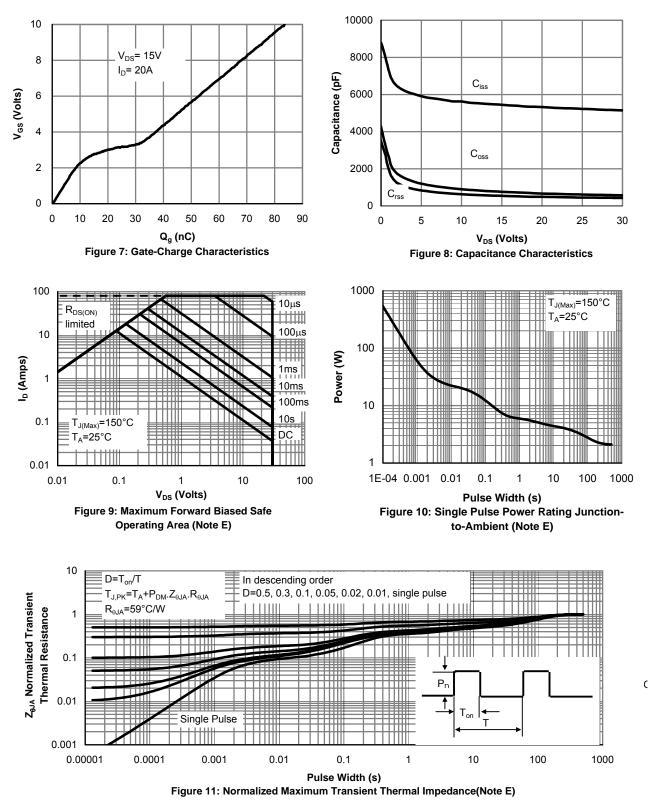
G.  $E_{AR}$  and  $I_{AR}$  ratings are based on low frequency and duty cycles to keep  $T_j$ =25C.

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